

## 650V N-Channel MOSFET

## **General Features**

- Advanced Planar Process
- $\triangleright$  R<sub>DS(ON),typ.</sub>=350 mΩ@V<sub>GS</sub>=10V
- Low Gate Charge Minimize Switching Loss
- Rugged Poly silicon Gate Structure

# **Applications**

- BLDC Motor Driver
- Electric Welder
- High Efficiency SMPS

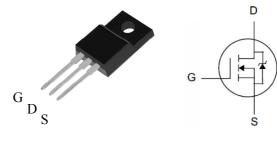
## **Ordering Information**

Part Number	Package	Brand
PTA22N65	TO-220F	ž

# Absolute Maximum Ratings

## (P) Lead Free Package and Finish

BV <sub>DSS</sub>	R <sub>DS(ON),typ.</sub>	I <sub>D</sub>
650V	350mΩ	22A



TO-220F Package

 $T_C \mbox{=} 25\,^\circ \mbox{C}$  unless otherwise specified

Symbol	Parameter	PTA22N65	Unit
V <sub>DSS</sub>	Drain-to-Source Voltage	650	V
V <sub>GSS</sub>	Gate-to-Source Voltage	±30	v
1	Continuous Drain Current	22	
ID	Continuous Drain Current @ Tc=100℃	14	A
I <sub>DM</sub>	Pulsed Drain Current at V <sub>GS</sub> =10V <sup>[2,4]</sup>	88	
E <sub>AS</sub>	Single Pulse Avalanche Energy	800	mJ
dv/dt	Peak Diode Recovery dv/dt <sup>[3]</sup>	5.0	V/ns
Б	Power Dissipation	75	W
P <sub>D</sub>	Derating Factor above 25℃	0.598	W/℃
T <sub>L</sub> T <sub>PAK</sub>	Maximum Temperature for Soldering Leads at 0.063in (1.6mm) from Case for 10 seconds, Package Body for 10 seconds	300 260	Ĉ
T <sub>J</sub> & T <sub>STG</sub>	Operating and Storage Temperature Range	-55 to 150	

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

## **Thermal Characteristics**

Symbol	Parameter	PTA22N65	Unit
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction-to-Case	1.67	20.000
R <sub>eja</sub>	Thermal Resistance, Junction-to-Ambient	100	°C <i>I</i> W

# **Electrical Characteristics**

1

## **OFF Characteristics** $T_J = 25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
BV <sub>DSS</sub>	Drain-to-Source Breakdown Voltage	650			V	$V_{GS}$ =0V, I <sub>D</sub> =250uA
	I <sub>DSS</sub> Drain-to-Source Leakage Current			1	uA	V <sub>DS</sub> =650V, V <sub>GS</sub> =0V
I <sub>DSS</sub>				125		V <sub>DS</sub> =520V, V <sub>GS</sub> =0V, T <sub>J</sub> =125℃
	Cate to Source Lookage Current			+100	<b>n</b> (	V <sub>GS</sub> =+30V, V <sub>DS</sub> =0V
I <sub>GSS</sub>	Gate-to-Source Leakage Current			-100	nA	V <sub>GS</sub> =-30V, V <sub>DS</sub> =0V

#### **ON Characteristics**

ON Characteristics				$T_J$ =25 $^\circ\!\!\!\!\!^\circ$ unless otherwise specified		
Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
R <sub>DS(ON)</sub>	Static Drain-to-Source On-Resistance		350	450	mΩ	V <sub>GS</sub> =10V, I <sub>D</sub> =11A
V <sub>GS(TH)</sub>	Gate Threshold Voltage	2.0		4.0	V	$V_{DS}$ = $V_{GS}$ , $I_D$ =250uA
gfs	Forward Transconductance		33		S	Vos =25V, Io=11A

#### **Dynamic Characteristics**

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
C <sub>iss</sub>	Input Capacitance		3500		pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1.0MH <sub>Z</sub>
C <sub>rss</sub>	Reverse Transfer Capacitance		240			
C <sub>oss</sub>	Output Capacitance		255			
Qg	Total Gate Charge		65			
Q <sub>gs</sub>	Gate-to-Source Charge		19		nC	$V_{DD}$ =325V, I <sub>D</sub> =22A, $V_{GS}$ =0 to 10V
Q <sub>gd</sub>	Gate-to-Drain (Miller) Charge		17			

## **Resistive Switching Characteristics**

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
td(ON)	Turn-on Delay Time		46			
trise	Rise Time		115		ns	V <sub>DD</sub> =325V, I <sub>D</sub> =11A, V <sub>GS</sub> = 10V RG=25Ω
td(OFF)	Turn-Off Delay Time		92			
tfall	Fall Time		105			

## **Source-Drain Body Diode Characteristics**

 $T_J {=} 25\,^\circ\!\mathrm{C}$  unless otherwise specified

Symbol	Parameter	Min	Тур.	Max.	Unit	Test Conditions
I <sub>SD</sub>	Continuous Source Current <sup>[2]</sup>			22	A	Integral PN-diode in MOSFET
I <sub>SM</sub>	Pulsed Source Current <sup>[2]</sup>			88		
$V_{SD}$	Diode Forward Voltage			1.5	V	I <sub>S</sub> =22A, V <sub>GS</sub> =0V
trr	Reverse recovery time		625		ns	V <sub>GS</sub> =0V ,I⊧=22A,
Qrr	Reverse recovery charge		5.0		uC	di⊧/dt=100A/µs

Note:

[1] T<sub>J</sub>=+25℃ to +150℃.

[2] Silicon limited current only.[3] Package limited current.

[4] Repetitive rating; pulse width limited by maximum junction temperature.
[5] Pulse width≤380µs; duty cycle≤2%.

## **Typical Characteristics**

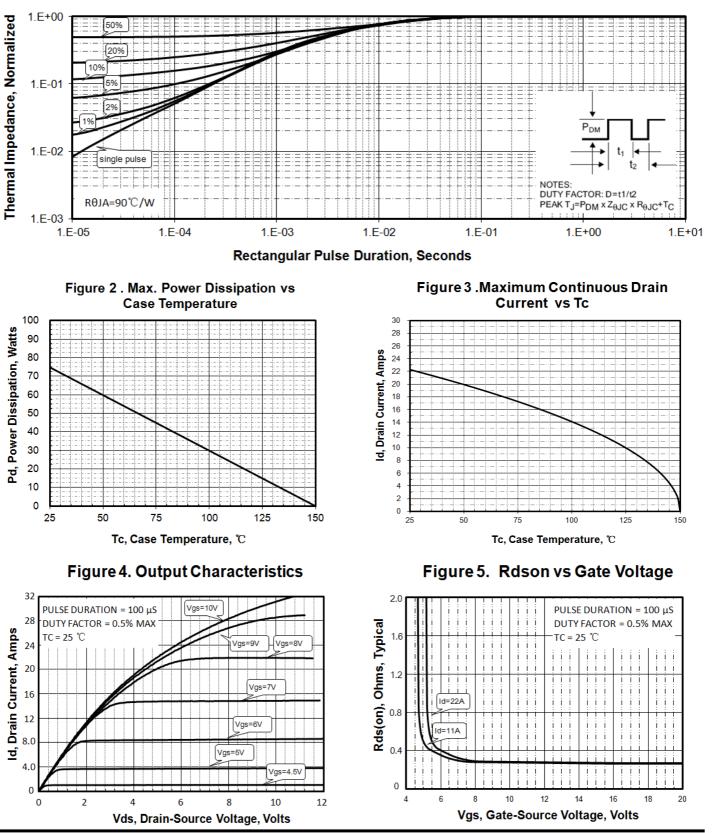
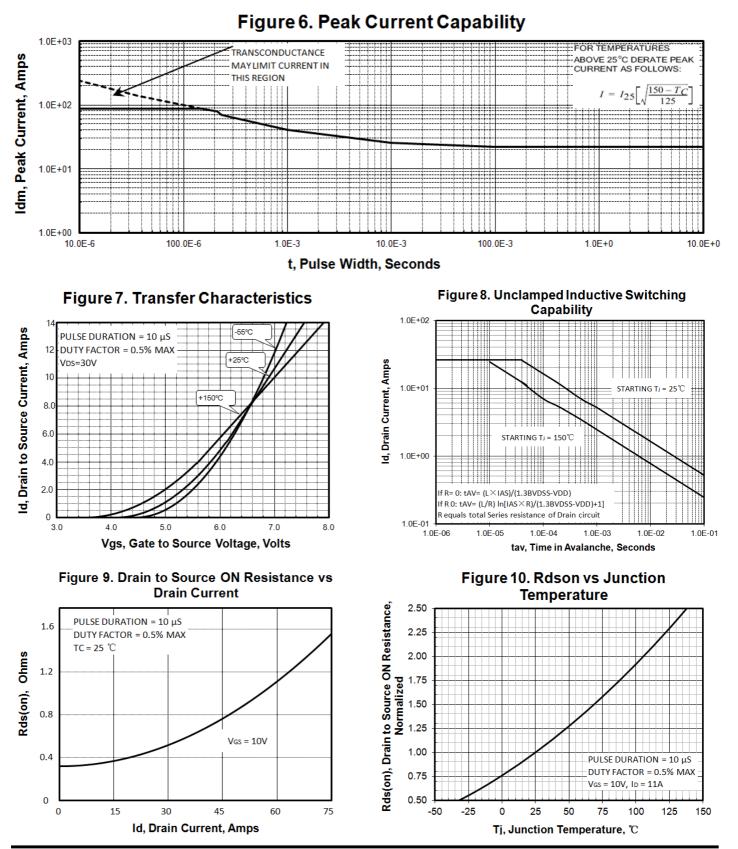
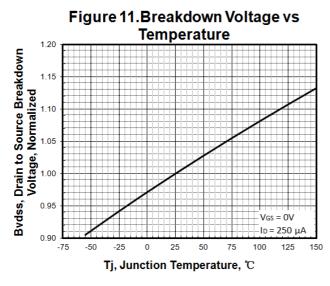


Figure 1. Maximum Transient Thermal Impedance

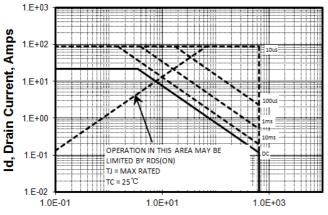
# Typical Characteristics(Cont.)



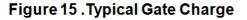
# Typical Characteristics(Cont.)







Vds, Drain Source Voltage, Volts



In=22/

Qg, Total gate charge (nC)

3751

10

8

6

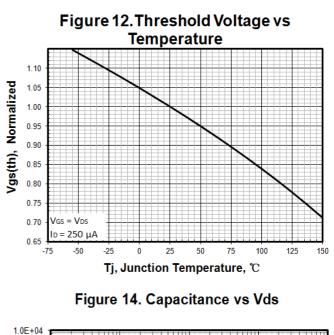
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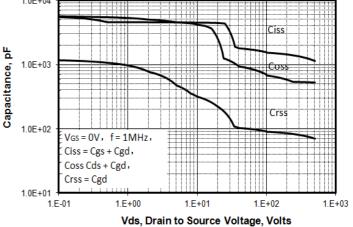
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0

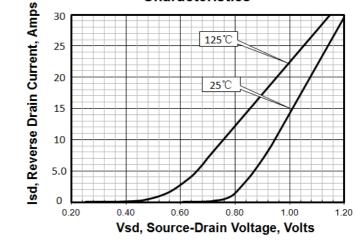
5 10 15 20 25 30 35 40 45 50 55 60 65 70 75

Vgs, gate to source voltage (v)





#### Figure 16.Body Diode Transfer Characteristics

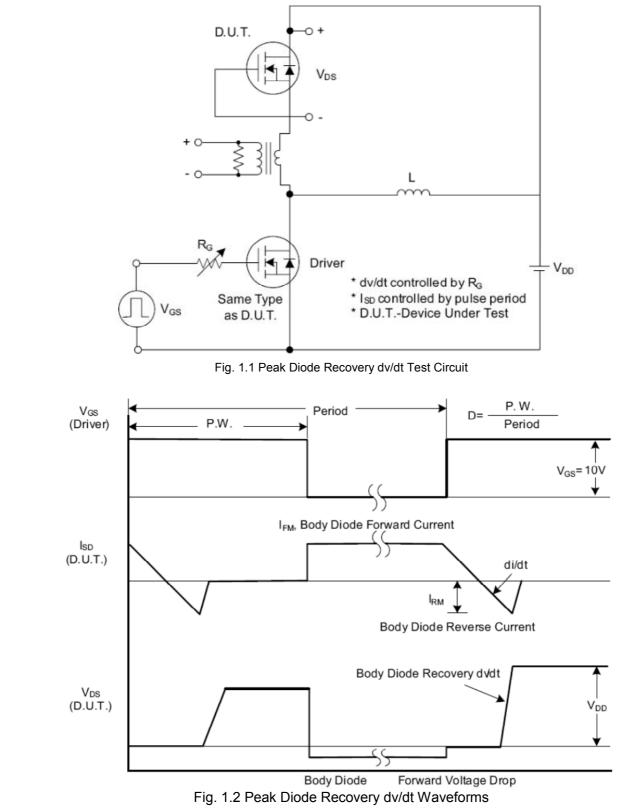


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# **Test Circuits and Waveforms**



# Test Circuits and Waveforms (Cont.)

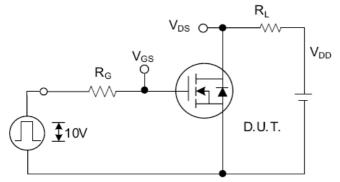


Fig. 2.1 Switching Test Circuit

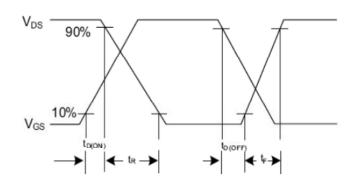


Fig. 2.2 Switching Waveforms

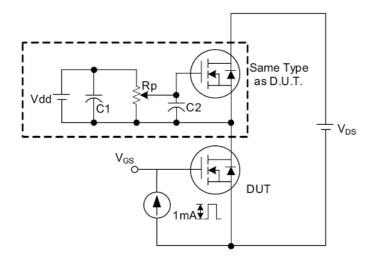


Fig. 3.1 Gate Charge Test Circuit

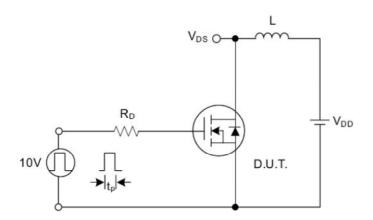


Fig. 4.1 Unclamped Inductive Switching Test Circuit

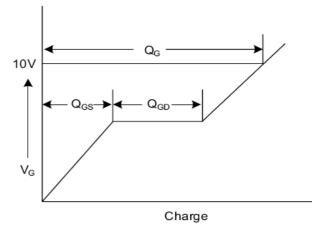
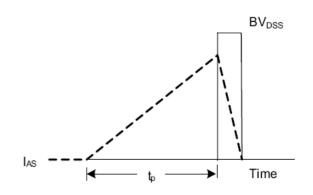
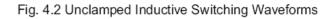


Fig. 3.2 Gate Charge Waveform





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